

Notice of References Cited	Application/Control No. 09/750,629	Applicant(s)/Patent Under Reexamination WANG ET AL.	
	Examiner Kim T. Huynh	Art Unit 2112	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,920,704 A	07-1999	Olnowich et al.	709/238
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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